


<div>Search Notes</div> <div></div>	Application/Control No.	Applicant(s)/Patent under Reexamination	
	10/694,148	PARSCHE, FRANCIS	
	Examiner	Art Unit	
	Shih-Chao Chen	2821	

SEARCHED			
Class	Subclass	Date	Examiner
343	741, 744, 748, 749, 788, 866	3/20/2006	CHEN

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner
343	744, 749	3/20/2006	CHEN

SEARCH NOTES (INCLUDING SEARCH STRATEGY)		
	DATE	EXMR
EAST (See attached printout).	3/20/2006	CHEN